Search Notes Application/Control No. Applicant(s)/Patent Under Reexamination LIU ET AL. Examiner Yuen, Kan Applicant(s)/Patent Under Reexamination LIU ET AL. 2416

SEARCHED					
Class	Subclass	Date	Examiner		
370	235	5/27/2008	KY		
370	395.21	5/27/2008	KY		
370	395.4	5/27/2008	KY		
370	395.41	5/27/2008	KY		
370	395.42	5/27/2008	KY		
370	411	5/27/2008	KY		
370	412	8/13/2008	KY		

SEARCH NOTES				
Search Notes	Date	Examiner		
EAST SEARCH CONSULTED WITH SPE	5/27/2008	KY		
MANUAL SEARCH CLASS 370 SUBCLASS 412	5/27/2008	KY		
INVENTORSHIP SEARCH	5/27/2008	KY		

INTERFERENCE SEARCH				
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